

64M-Bit (4Mx16 /2Mx32) CMOS MASK ROM

FEATURES

- Switchable organization
4,194,304 x 16(word mode)
2,097,152 x 32(double word mode)
- Fast access time
Random Access/Page Access
3.3V Operation : 100/30ns(Max.)
3.0V Operation : 120/40ns(Max.)
4 double Words / 8 Words page access
- Supply voltage : single +3.0V/ single +3.3V
- Current consumption
Operating : 60mA(Max.)
Standby : 30μA(Max.)
- Fully static operation
- All inputs and outputs TTL compatible
- Three state outputs
- Package
- . KM23V64205ASG : 70-SSOP-500

GENERAL DESCRIPTION

The KM23V64205ASG is a fully static mask programmable ROM fabricated using silicon gate CMOS process technology, and is organized either as 4,194,304 x 16 bit(word mode) or as 2,097,152 x 32 bit(double word mode) depending on WORD voltage level.(See mode selection table)

This device includes page read mode function, page read mode allows 4 double words (or 8 words) of data to read fast in the same page, $\overline{CE}$ and $A_2 \sim A_{20}$ should not be changed.

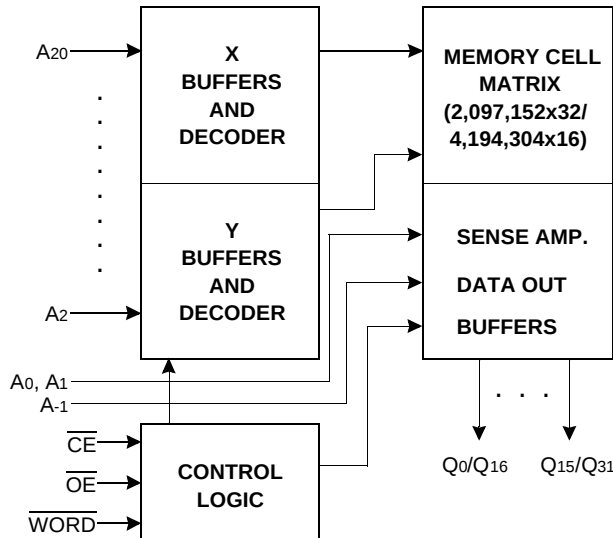
This device operates with 3.0V or 3.3V power supply, and all inputs and outputs are TTL compatible.

Because of its asynchronous operation, it requires no external clock assuring extremely easy operation.

It is suitable for use in program memory of microprocessor, and data memory, character generator.

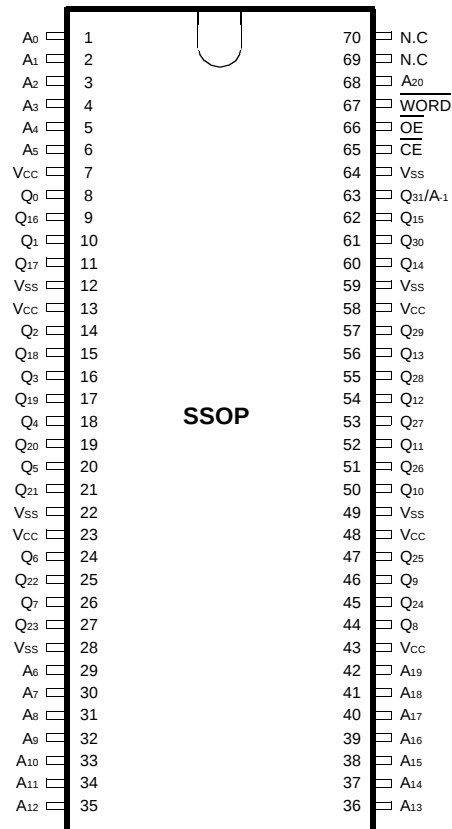
The KM23V64205ASG is packaged in a 70-SSOP.

FUNCTIONAL BLOCK DIAGRAM



Pin Name	Pin Function
A0 - A1	Page Address Inputs
A2 - A20	Address Inputs
Q0 - Q30	Data Outputs
Q31 /A-1	Output 31(Double word mode)/ LSB Address(Word mode)
$\overline{WORD}$	Double word/Word mode selection
$\overline{CE}$	Chip Enable
$\overline{OE}$	Output Enable
Vcc	Power
Vss	Ground
N.C	No Connection

PIN CONFIGURATION



KM23V64205ASG

ABSOLUTE MAXIMUM RATINGS

Item	Symbol	Rating	Unit
Voltage on Any Pin Relative to Vss	V _{IN}	-0.3 to +4.5	V
Temperature Under Bias	T _{BIAS}	-10 to +85	°C
Storage Temperature	T _{STG}	-55 to +150	°C

NOTE : Permanent device damage may occur if "ABSOLUTE MAXIMUM RATINGS" are exceeded. Functional operation should be restricted to the conditions as detailed in the operational sections of this data sheet. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

RECOMMENDED OPERATING CONDITIONS(Voltage reference to V_{ss}, T_A=0 to 70°C)

Item	Symbol	Min	Typ	Max	Unit
Supply Voltage	V _{CC}	2.7/3.0	3.0/3.3	3.3/3.6	V
Supply Voltage	V _{SS}	0	0	0	V

DC CHARACTERISTICS

Parameter	Symbol	Test Conditions	Min	Max	Unit
Operating Current	I _{CC}	$\overline{CE}=\overline{OE}=V_{IL}$, all outputs open	-	60	mA
		V _{CC} =3.3V±0.3V		50	mA
Standby Current(TTL)	I _{SB1}	$\overline{CE}=V_{IH}$, all outputs open		500	μA
Standby Current(CMOS)	I _{SB2}	$\overline{CE}=V_{CC}$, all outputs open		30	μA
Input Leakage Current	I _{LI}	V _{IN} =0 to V _{CC}	-	10	μA
Output Leakage Current	I _{LO}	V _{OUT} =0 to V _{CC}	-	10	μA
Input High Voltage, All Inputs	V _{IH}		2.0	V _{CC} +0.3	V
Input Low Voltage, All Inputs	V _{IL}		-0.3	0.6	V
Output High Voltage Level	V _{OH}	I _{OH} =-400μA	2.4	-	V
Output Low Voltage Level	V _{OL}	I _{OL} =2.1mA	-	0.4	V

NOTE : Minimum DC Voltage(V_{IL}) is -0.3V on input pins. During transitions, this level may undershoot to -2.0V for periods <20ns.
Maximum DC voltage on input pins(V_{IH}) is V_{CC}+0.3V which, during transitions, may overshoot to V_{CC}+2.0V for periods <20ns.

MODE SELECTION

$\overline{CE}$	$\overline{OE}$	WORD	Q ₃₁ /A-1	Mode	Data	Power
H	X	X	X	Standby	High-Z	Standby
L	H	X	X	Operating	High-Z	Active
L	L	H	Output	Operating	Q ₀ ~Q ₃₁ :Dout	Active
		L	Input	Operating	Q ₀ ~Q ₁₅ : Dout Q ₁₆ ~Q ₃₀ : Hi-Z	Active

CAPACITANCE(T_A=25°C, f=1.0MHz)

Item	Symbol	Test Conditions	Min	Max	Unit
Output Capacitance	C _{OUT}	V _{OUT} =0V	-	12	pF
Input Capacitance	C _{IN}	V _{IN} =0V	-	12	pF

NOTE : Capacitance is periodically sampled and not 100% tested.

AC CHARACTERISTICS (TA=0°C to 70°C, VCC=3.3V/3.0V±0.3V, unless otherwise noted.)

TEST CONDITIONS

Item	Value
Input Pulse Levels	0.45V to 2.4V
Input Rise and Fall Times	10ns
Input and Output timing Levels	1.5V
Output Loads	1 TTL Gate and CL=100pF

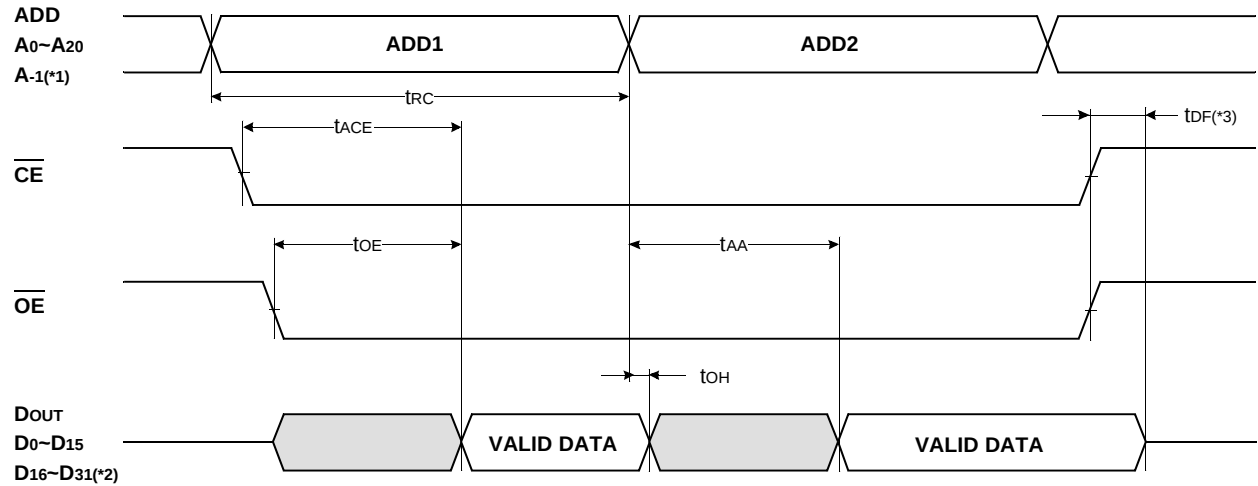
READ CYCLE

Item	Symbol	VCC=3.3V±0.3V		VCC=3.0V±0.3V		Unit
		Min	Max	Min	Max	
Read Cycle Time	tRC	100		120		ns
Chip Enable Access Time	tACE		100		120	ns
Address Access Time	tAA		100		120	ns
Page Address Access Time	tPA		30		40	ns
Output Enable Access Time	tOE		30		40	ns
Output or Chip Disable to Output High-Z	tDF		20		20	ns
Output Hold from Address Change	tOH	0		0		ns

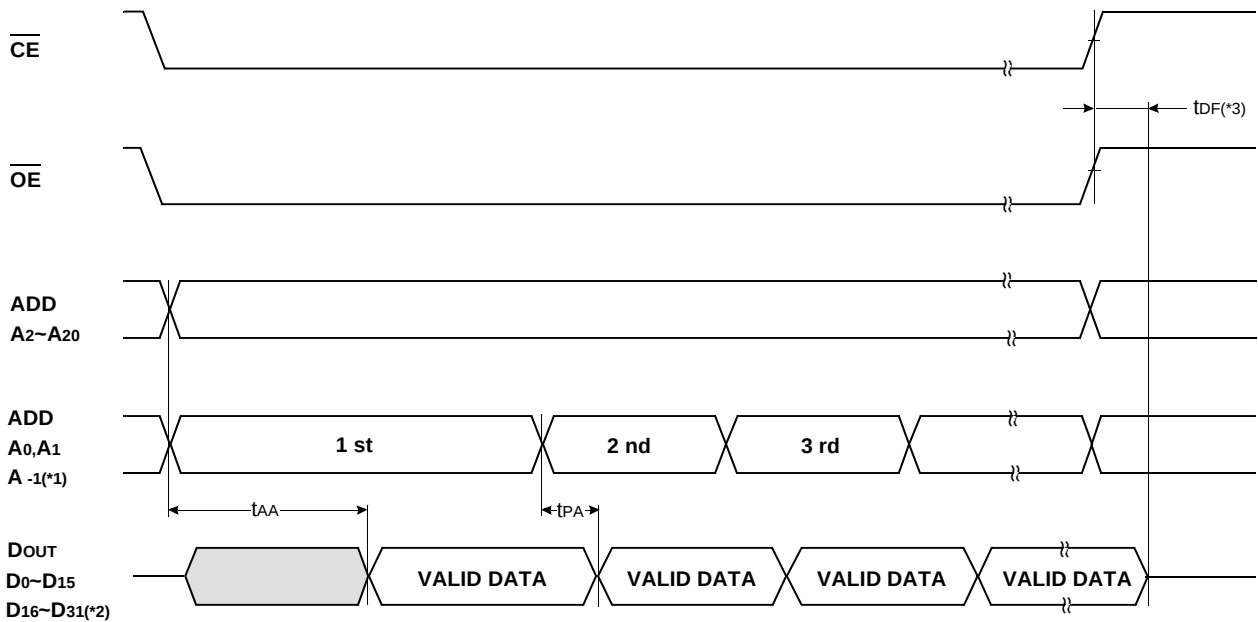
NOTE : Page Address is determined as below.
 Double Word mode (WORD=V_{IH}) : A₀, A₁
 Word mode (WORD=V_{IL}) : A₋₁, A₀, A₁

TIMING DIAGRAM

READ



PAGE READ



NOTES :

*1. Word Mode only. A-1 is Least Significant Bit Address. (WORD = V_{IL})

*2. Double Word Mode only. (WORD = V_{IH})

*3. t_{DF} is defined as the time at which the outputs achieve the open circuit condition and is not referenced to V_{OH} or V_{OL} level.

PACKAGE DIMENSIONS

